

2.5 V/3.3 V Any Level Positive Input to -3.3 V/-5.5 V NECL Output Translator MC100EP91

Description

The MC100EP91 is a triple any level positive input to NECL output translator. The device accepts LVPECL, LVTTTL, LVCMOS, HSTL, CML or LVDS signals, and translates them to differential NECL output signals ($-3.0\text{ V}/-5.5\text{ V}$).

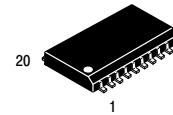
To accomplish the level translation the EP91 requires three power rails. The V_{CC} pins should be connected to the positive power supply, and the V_{EE} pin should be connected to the negative power supply. The GND pins are connected to the system ground plane. Both V_{EE} and V_{CC} should be bypassed to ground via $0.01\text{ }\mu\text{F}$ capacitors.

Under open input conditions, the $\bar{D}$ input will be biased at $V_{CC}/2$ and the D input will be pulled to GND. These conditions will force the Q outputs to a low state, and Q outputs to a high state, which will ensure stability.

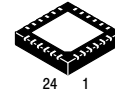
The V_{BB} pin, an internally generated voltage supply, is available to this device only. For single-ended input conditions, the unused differential input is connected to V_{BB} as a switching reference voltage. V_{BB} may also rebias AC coupled inputs. When used, decouple V_{BB} and V_{CC} via a $0.01\text{ }\mu\text{F}$ capacitor and limit current sourcing or sinking to 0.5 mA . When not used, V_{BB} should be left open.

Features

- Maximum Input Clock Frequency = $> 2.0\text{ GHz}$ Typical
- Maximum Input Data Rate = $> 2.0\text{ Gb/s}$ Typical
- 500 ps Typical Propagation Delay
- Operating Range:
 $V_{CC} = 2.375\text{ V}$ to 3.8 V ; $V_{EE} = -3.0\text{ V}$ to -5.5 V ; $GND = 0\text{ V}$
- Q Output will Default LOW with Inputs Open or at GND
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

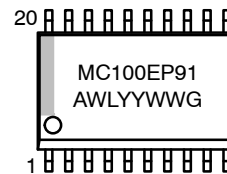


SOIC-20 WB
DW SUFFIX
CASE 751D

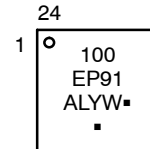


QFN-24
MN SUFFIX
CASE 485L

MARKING DIAGRAMS*



SOIC-20 WB



QFN-24

A = Assembly Location
WL, L = Wafer Lot
YY, Y = Year
WW, W = Work Week
G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

*For additional marking information, refer to Application Note [AND8002/D](#).

ORDERING INFORMATION

Device	Package	Shipping [†]
MC100EP91MNG	QFN-24 (Pb-Free)	92 Units / Tube

DISCONTINUED (Note 1)

MC100EP91DWG	SOIC-20 WB (Pb-Free)	38 Units / Tube
MC100EP91DWR2G	SOIC-20 WB (Pb-Free)	1000 Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, [BRD8011/D](#).

- DISCONTINUED:** This device is not recommended for new design. Please contact your onsemi representative for information. The most current information on this device may be available on www.onsemi.com.

MC100EP91

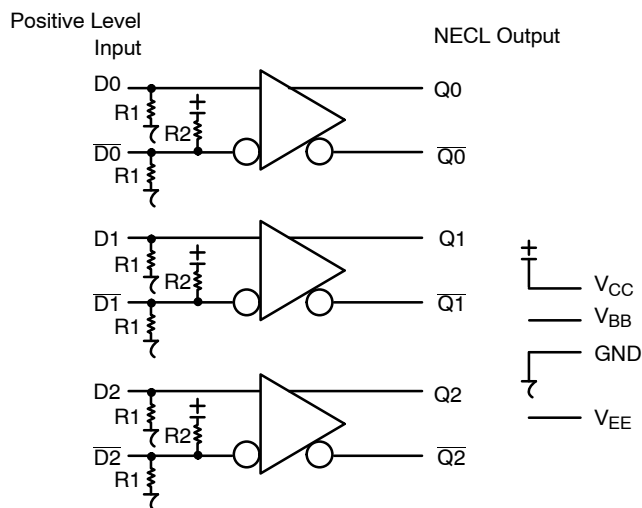


Figure 1. Logic Diagram

Table 1. PIN DESCRIPTION

Pin		Name	I/O	Default State	Description
SOIC	QFN				
1, 20	3, 4, 12	V _{CC}	–	–	Positive Supply Voltage. All V _{CC} Pins must be Externally Connected to Power Supply to Guarantee Proper Operation
10	15, 16	V _{EE}	–	–	Negative Supply Voltage. All V _{EE} Pins must be Externally Connected to Power Supply to Guarantee Proper Operation
14, 17	19, 20, 23, 24	GND	–	–	Ground
4, 7	7, 11	V _{BB}	–	–	ECL Reference Voltage Output
2, 5, 8	5, 8, 13	D[0:2]	LVPECL, LVDS, LVTTTL, LVCMOS, CML, HSTL Input	Low	Noninverted Differential Inputs [0:2]. Internal 75 kΩ to GND.
3, 6, 9	6, 9, 14	$\overline{D}$ [0:2]	LVPECL, LVDS, LVTTTL, LVCMOS, CML, HSTL Input	High	Inverted Differential Inputs [0:2]. Internal 75 kΩ to GND and 75 kΩ to V _{CC} . When Inputs are Left Open They Default to (V _{CC} – GND) / 2
19, 16, 13	2, 22, 18	Q[0:2]	NECL Output	–	Noninverted Differential Outputs [0:2]. Typically Terminated with 50 Ω to V _{TT} = V _{CC} – 2 V
18, 15, 12	1, 21, 17	$\overline{Q}$ [0:2]	NECL Output	–	Inverted Differential Outputs [0:2]. Typically Terminated with 50 Ω to V _{TT} = V _{CC} – 2 V
11	10	NC	–	–	No Connect. The NC Pin is NOT Electrically Connected to the Die and may Safely be Connected to Any Voltage from V _{EE} to V _{CC}
N/A	–	EP	–	–	Exposed Pad (Note 1)

1. The thermally conductive exposed pad on the package bottom (see case drawing) must be attached to a heat-sinking conduit and may only be electrically connected to V_{EE} (not GND).

MC100EP91

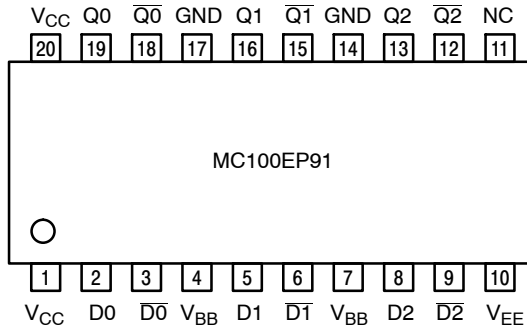


Figure 2. SOIC-20 Lead Pinout (Top View)

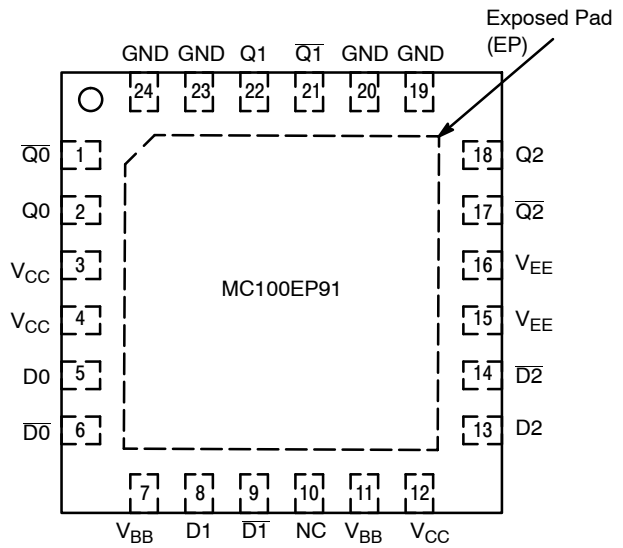


Figure 3. QFN-24 Lead Pinout (Top View)*

*All V_{CC}, V_{EE} and GND pins must be externally connected to a power supply and the underside exposed pad must be attached to an adequate heat-sinking conduit to guarantee proper operation.

Table 2. ATTRIBUTES

Characteristics	Value
Internal Input Pulldown Resistor (R1)	75 kΩ
Internal Input Pullup Resistor (R2)	75 kΩ
ESD Protection Human Body Model Machine Model Charged Device Model	> 2 kV > 150 V > 2 kV
Moisture Sensitivity (Note 1)	Pb-Free Pkg
SOIC-20 WB QFN-24	Level 3 Level 1
Flammability Rating Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in
Transistor Count	446 Devices
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test	

1. For additional information, see Application Note [AND8003/D](#).

MC100EP91

Table 3. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V _{CC}	Positive Power Supply	GND = 0 V		3.8 to 0	V
V _{EE}	Negative Power Supply	GND = 0 V		–6	V
V _I	Positive Input Voltage	GND = 0 V	V _I ≤ V _{CC}	3.8 to 0	V
V _{OP}	Operating Voltage	GND = 0 V	V _{CC} – V _{EE}	9.8	V
I _{out}	Output Current	Continuous Surge		50 100	mA
I _{BB}	PECL V _{BB} Sink/Source			±0.5	mA
T _A	Operating Temperature Range			–40 to +85	°C
T _{stg}	Storage Temperature Range			–65 to +150	°C
θ _{JA}	Thermal Resistance (Junction-to-Ambient) JESD 51–3 (1S-Single Layer Test Board)	0 lfpm 500 lfpm	SOIC–20 WB SOIC–20 WB	90 60	°C/W
θ _{JA}	Thermal Resistance (Junction-to-Ambient) JESD 51–6 (2S2P Multilayer Test Board) with Filled Thermal Vias	0 lfpm 500 lfpm	QFN–24 QFN–24	37 32	°C/W
θ _{JC}	Thermal Resistance (Junction-to-Case)	Standard Board	SOIC–20 WB QFN–24	30 to 35 11	°C/W
T _{sol}	Wave Solder (Pb-Free)			225	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 4. DC CHARACTERISTICS POSITIVE INPUTS (V_{CC} = 2.5 V, V_{EE} = –3.0 V to –5.5 V, GND = 0 V (Note 1))

Symbol	Characteristic	–40°C			25°C			85°C			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
I _{CC}	Positive Power Supply Current	10	14	20	10	14	20	10	14	20	mA
V _{IH}	Input HIGH Voltage (Single-Ended)	1335		V _{CC}	1335		V _{CC}	1335		V _{CC}	mV
V _{IL}	Input LOW Voltage (Single-Ended)	GND		875	GND		875	GND		875	mV
V _{IHCMR}	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 2)	0		2.5	0		2.5	0		2.5	V
I _{IH}	Input HIGH Current (@ V _{IH})			150			150			150	μA
I _{IL}	Input LOW Current (@ V _{IL})										μA
	D	0.5			0.5			0.5			
	$\bar{D}$	–150			–150			–150			

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

1. Input parameters vary 1:1 with V_{CC}. V_{CC} can vary +1.3 V / –0.125 V.
2. V_{IHCMR} min varies 1:1 with GND. V_{IHCMR} max varies 1:1 with V_{CC}.

MC100EP91

Table 5. DC CHARACTERISTICS POSITIVE INPUT ($V_{CC} = 3.3 \text{ V}$; $V_{EE} = -3.0 \text{ V}$ to -5.5 V ; $GND = 0 \text{ V}$ (Note 1))

Symbol	Characteristic	-40°C			25°C			85°C			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
I_{CC}	Positive Power Supply Current	10	16	24	10	16	24	10	16	24	mA
V_{IH}	Input HIGH Voltage (Single-Ended)	2135		V_{CC}	2135		V_{CC}	2135		V_{CC}	mV
V_{IL}	Input LOW Voltage (Single-Ended)	GND		1675	GND		1675	GND		1675	mV
V_{BB}	PECL Output Voltage Reference	1775	1875	1975	1775	1875	1975	1775	1875	1975	mV
V_{IHCMR}	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 2)	0		3.3	0		3.3	0		3.3	V
I_{IH}	Input HIGH Current (@ V_{IH})			150			150			150	μA
I_{IL}	Input LOW Current (@ V_{IL}) D $\bar{D}$	0.5 -150			0.5 -150			0.5 -150			μA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

1. Input parameters vary 1:1 with V_{CC} . V_{CC} can vary $+0.5 / -0.925 \text{ V}$.
2. V_{IHCMR} min varies 1:1 with GND. V_{IHCMR} max varies 1:1 with V_{CC} .

Table 6. DC CHARACTERISTICS NECL OUTPUT ($V_{CC} = 2.375 \text{ V}$ to 3.8 V ; $V_{EE} = -3.0 \text{ V}$ to -5.5 V ; $GND = 0 \text{ V}$ (Note 1))

Symbol	Characteristic	-40°C			25°C			85°C			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
I_{EE}	Negative Power Supply Current	40	50	60	38	50	68	38	50	68	mA
V_{OH}	Output HIGH Voltage (Note 2)	-1145	-1020	-895	-1145	-1020	-895	-1145	-1020	-895	mV
V_{OL}	Output LOW Voltage (Note 2)	-1945	-1770	-1600	-1945	-1770	-1600	-1945	-1770	-1600	mV

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

1. Output parameters vary 1:1 with GND.
2. All loading with 50Ω resistor to GND - 2.0 V.

MC100EP91

Table 7. AC CHARACTERISTICS ($V_{CC} = 2.375 \text{ V to } 3.8 \text{ V}$; $V_{EE} = -3.0 \text{ V to } -5.5 \text{ V}$; $GND = 0 \text{ V}$)

Symbol	Characteristic	-40°C			25°C			85°C			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
V_{OUTPP}	Output Voltage Amplitude (Figure 4) (Note 1) $f_{in} \leq 1.0 \text{ GHz}$ $f_{in} \leq 1.5 \text{ GHz}$ $f_{in} \leq 2.0 \text{ GHz}$	575 525 300	800 750 600		600 525 250	800 750 550		550 400 150	800 750 500		mV
t_{PLH} t_{PHL}	Propagation Delay D to Q Differential Single-Ended	375 300	500 450	600 650	375 300	500 450	600 675	400 300	550 500	650 750	ps
t_{SKEW}	Pulse Skew (Note 2) Output-to-Output (Note 3) Part-to-Part (Diff) (Note 3)		15 25 50	75 95 125		15 30 50	75 105 125		15 30 70	80 105 150	ps
t_{JITTER}	RMS Random Clock Jitter (Note 4) Peak-to-Peak Data Dependant Jitter (Note 5) $f_{in} = 2.0 \text{ GHz}$ $f_{in} = 2.0 \text{ Gb/s}$		0.5 20	2.0		0.5 20	2.0		0.5 20	2.0	ps
V_{INPP}	Input Voltage Swing (Differential Configuration) (Note 6)	200	800	1200	200	800	1200	200	800	1200	mV
t_r, t_f	Output Rise/Fall Times @ 50 MHz (20%–80%) Q, Q	75	150	250	75	150	250	75	150	275	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm.

1. Measured using a 750 mV source, 50% duty cycle clock source. All loading with 50Ω to GND – 2.0 V. Input edge rates 150 ps (20% – 80%).
2. Pulse Skew = $|t_{PLH} - t_{PHL}|$
3. Skews are valid across specified voltage range, part-to-part skew is for a given temperature.
4. RMS Jitter with 50% Duty Cycle Input Clock Signal.
5. Peak-to-Peak Jitter with input NRZ PRBS $2^{31}-1$ at 2.0 Gb/s.
6. Input voltage swing is a Single-Ended measurement operating in differential mode. The device has a DC gain of ≈ 50 .

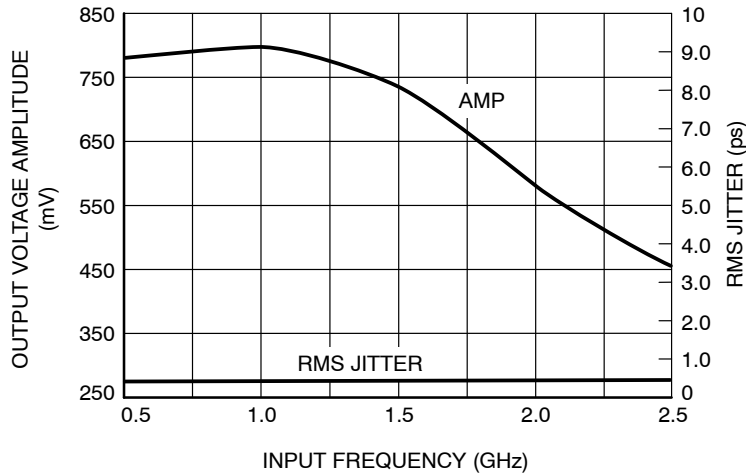


Figure 4. Output Voltage Amplitude (V_{OUTPP}) / RMS Jitter vs. Input Frequency (f_{in}) at Ambient Temperature (Typical)

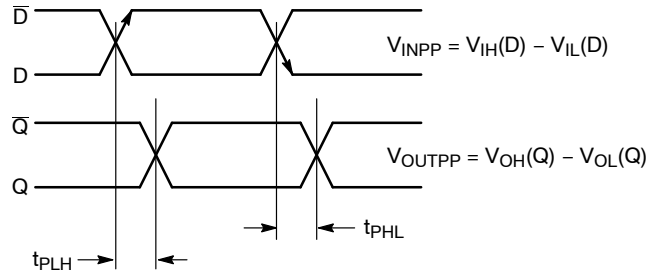


Figure 5. AC Reference Measurement

Application Information

All MC100EP91 inputs can accept LVPECL, LVTTTL, LVCMOS, HSTL, CML, or LVDS signal levels. The limitations for differential input signal (LVDS, HSTL, LVPECL, or CML) are the minimum input swing of 150 mV

and the maximum input swing of 3.0 V. Within these conditions, the input voltage can range from V_{CC} to GND. Examples interfaces are illustrated below in a 50 Ω environment ($Z = 50 \Omega$).

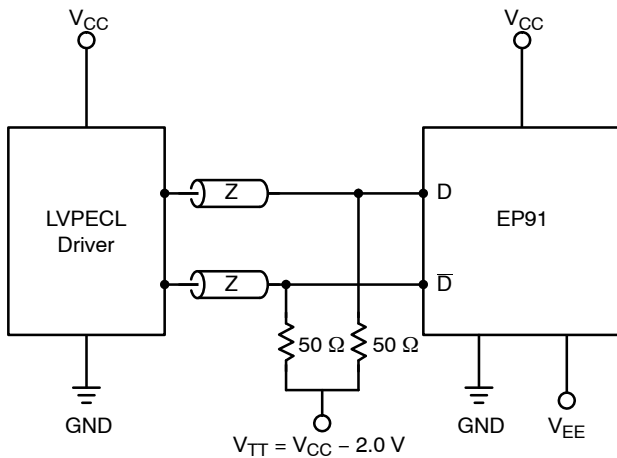


Figure 6. Standard LVPECL Interface

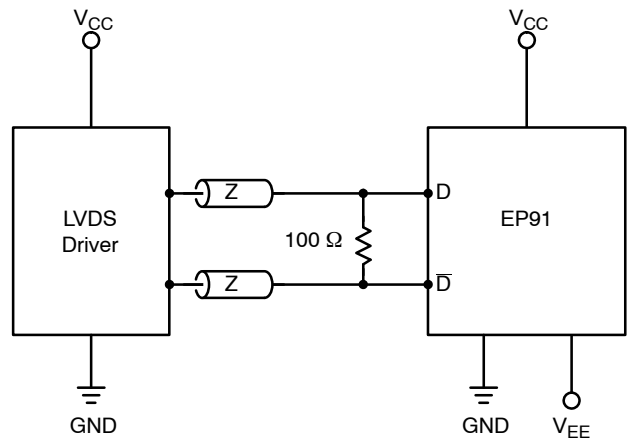


Figure 7. Standard LVDS Interface

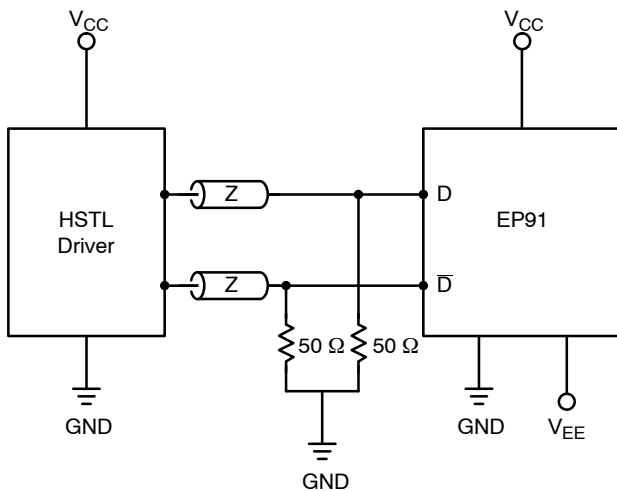


Figure 8. Standard HSTL Interface

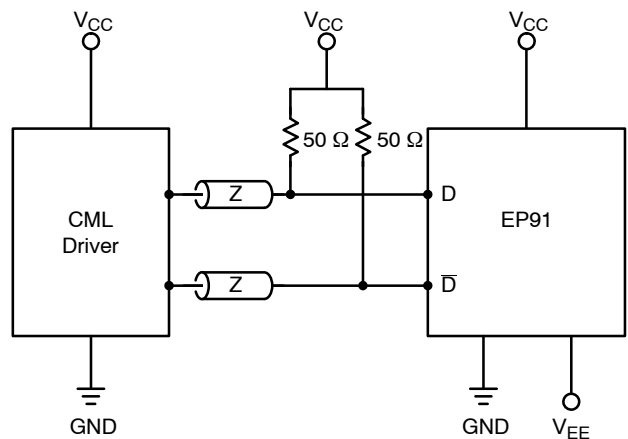


Figure 9. Standard 50 Ω Load CML Interface

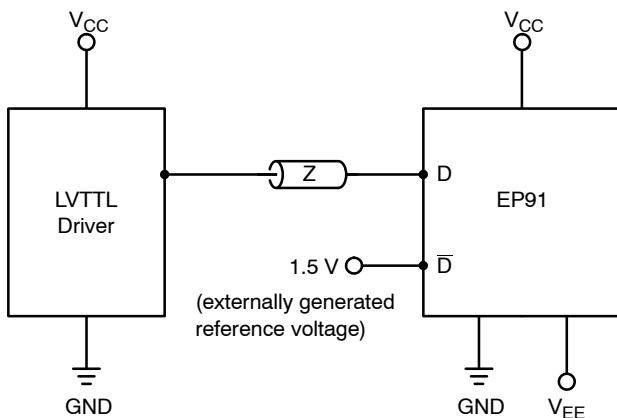


Figure 10. Standard LVTTTL Interface

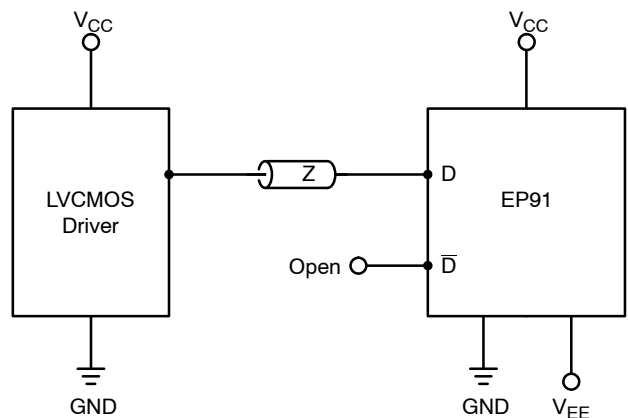


Figure 11. Standard LVCMOS Interface
($\bar{D}$ will default to $V_{CC}/2$ when left open.
A reference voltage of $V_{CC}/2$ should be applied to D input, if $\bar{D}$ is interfaced to CMOS signals)

MC100EP91

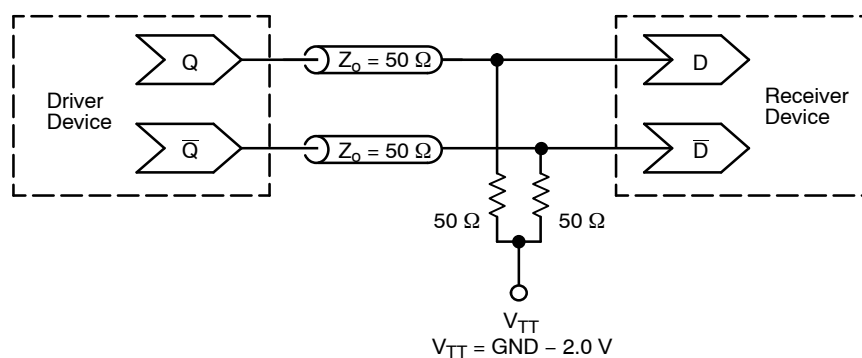
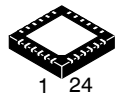


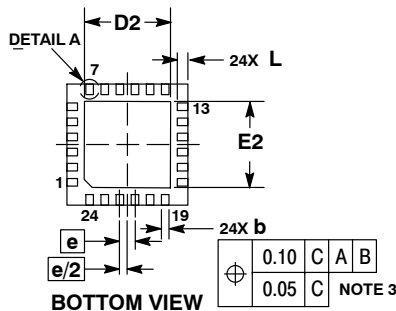
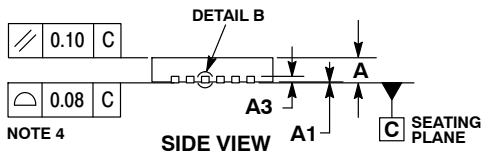
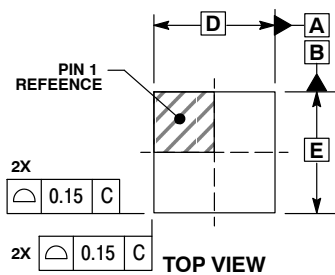
Figure 12. Typical Termination for Output Driver and Device Evaluation
(See Application Note [AND8020/D](#) – Termination of ECL Logic Devices)

Resource Reference of Application Notes

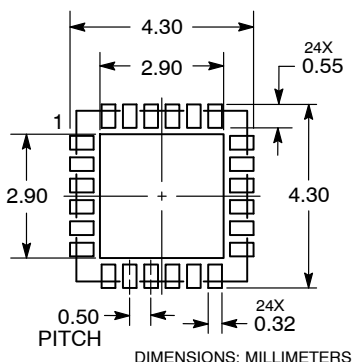
- AN1405/D** – ECL Clock Distribution Techniques
- AN1406/D** – Designing with PECL (ECL at +5.0 V)
- AN1503/D** – ECLinPS™ I/O SPiCE Modeling Kit
- AN1504/D** – Metastability and the ECLinPS Family
- AN1568/D** – Interfacing Between LVDS and ECL
- AN1672/D** – The ECL Translator Guide
- AND8001/D** – Odd Number Counters Design
- AND8002/D** – Marking and Date Codes
- AND8020/D** – Termination of ECL Logic Devices
- AND8066/D** – Interfacing with ECLinPS
- AND8090/D** – AC Characteristics of ECL Devices



SCALE 2:1



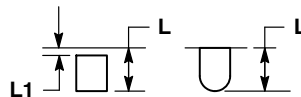
RECOMMENDED SOLDERING FOOTPRINT



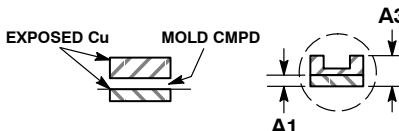
DIMENSIONS: MILLIMETERS

QFN24, 4x4, 0.5P CASE 485L ISSUE B

DATE 05 JUN 2012



DETAIL A
ALTERNATE
CONSTRUCTIONS



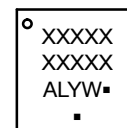
DETAIL B
ALTERNATE TERMINAL
CONSTRUCTIONS

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM THE TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

DIM	MILLIMETERS	
	MIN	MAX
A	0.80	1.00
A1	0.00	0.05
A3	0.20	REF
b	0.20	0.30
D	4.00	BSC
D2	2.70	2.90
E	4.00	BSC
E2	2.70	2.90
e	0.50	BSC
L	0.30	0.50
L1	0.05	0.15

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code
A = Assembly Location
L = Wafer Lot
Y = Year
W = Work Week
▪ = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

*For additional information on our Pb-Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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